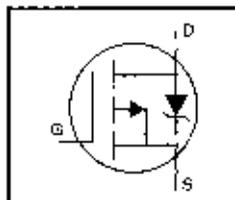


**HEXFET<sup>®</sup> Power MOSFET**

- Dynamic  $dv/dt$  Rating
- Repetitive Avalanche Rated
- P-Channel
- 175°C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements



$$V_{DSS} = -100V$$

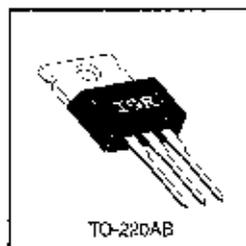
$$R_{DS(on)} = 0.60\Omega$$

$$I_D = -6.8A$$

**Description**

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contributes to its wide acceptance throughout the industry.


**DATA  
SHEETS**
**Absolute Maximum Ratings**

Parameter	Max.	Units
$I_D$ @ $T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$	-6.8
$I_D$ @ $T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ -10V$	-4.8
$I_{DM}$	Pulsed Drain Current (1)	-27
$P_D$ @ $T_C = 25^\circ C$	Power Dissipation	60
	Linear Derating Factor	0.40
$V_{GS}$	Gate-to-Source Voltage	±20
$E_{AS}$	Single Pulse Avalanche Energy (2)	300
$I_{AS}$	Avalanche Current (2)	-6.8
$E_{AR}$	Repetitive Avalanche Energy (2)	6.0
$dv/dt$	Peak Diode Recovery $dv/dt$ (3)	-6.5
$T_J$	Operating Junction and Storage Temperature Range	-55 to +175
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)
	Mounting Torque, 6-32 or M3 screw	10 lbf-in (1.1 N-m)

**Thermal Resistance**

Parameter	Min.	Typ.	Max.	Units
$R_{JC}$	Junction-to-Case	—	2.5	°C/W
$R_{JCS}$	Case-to-Sink, Flat, Greased Surface	—	0.50	°C/W
$R_{JA}$	Junction-to-Ambient	—	62	°C/W

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$V_{DS(BR)}$	Drain-to-Source Breakdown Voltage	-100	—	—	V	$V_{GS}=0\text{V}$ , $I_D=-250\mu\text{A}$
$\Delta V_{DS(BR)}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.10	—	$\text{mV}/^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D=-1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.80	$\Omega$	$V_{GS}=-10\text{V}$ , $I_D=-4.1\text{A}$ $\text{①}$
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$
$g_m$	Forward Transconductance	2.0	—	—	$\text{S}$	$V_{DS}=-50\text{V}$ , $I_D=-4.1\text{A}$ $\text{②}$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	-100	$\mu\text{A}$	$V_{DS}=100\text{V}$ , $V_{GS}=0\text{V}$
		—	—	-500		$V_{DS}=-80\text{V}$ , $V_{GS}=0\text{V}$ , $T_J=150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{DS}=-20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{DS}=20\text{V}$
$Q_g$	Total Gate Charge	—	—	18	nC	$I_D=-8.8\text{A}$
$Q_{GS}$	Gate-to-Source Charge	—	—	3.0		$V_{DS}=-80\text{V}$
$Q_{GD}$	Gate-to-Drain ("Miller") Charge	—	—	9.0		$V_{GS}=-10\text{V}$ See Fig. 6 and 13 $\text{③}$
$t_{turn(on)}$	Turn-On Delay Time	—	9.6	—	ns	$V_{DS}=50\text{V}$
$t_r$	Rise Time	—	29	—		$I_D=-8.8\text{A}$
$t_{turn(off)}$	Turn-Off Delay Time	—	21	—		$R_{\theta J-C}=18^\circ\text{C/W}$
$t_f$	Fall Time	—	25	—		$R_{\theta J-C}=7.112$ See Figure 10 $\text{④}$
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 8 mm (0.25 in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	390	—	pF	$V_{DS}=0\text{V}$
$C_{oss}$	Output Capacitance	—	170	—		$V_{DS}=25\text{V}$
$C_{res}$	Reverse Transfer Capacitance	—	45	—		$f=1.0\text{MHz}$ See Figure 5


**Source-Drain Ratings and Characteristics**

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-6.6	A	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) $\text{①}$	—	—	-27		
$V_{SD}$	Diode Forward Voltage	—	—	-6.3	V	$T_J=25^\circ\text{C}$ , $I_S=-6.6\text{A}$ , $V_{GS}=0\text{V}$ $\text{②}$
$t_r$	Reverse Recovery Time	—	98	200	ns	$T_J=25^\circ\text{C}$ , $I_S=-6.6\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	0.33	0.65	$\mu\text{C}$	$dI/dt=100\text{A}/\mu\text{s}$ $\text{③}$
$t_{on}$	Forward Turn-On Time	—	—	—		$\text{④}$ Intrinsic turn-on time is negligible; (turn-on is dominated by $L_S+L_D$ )

**Notes:**

- $\text{①}$  Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)  
 $\text{②}$   $I_{DSS}=8.8\text{A}$ ,  $dI/dt < 110\text{A}/\mu\text{s}$ ,  $V_{GS}=0\text{V}$ ,  $R_{\theta J-C}$ ,  $T_J \leq 175^\circ\text{C}$   
 $\text{③}$   $V_{DS}=-25\text{V}$ , starting  $T_J=25^\circ\text{C}$ ,  $L=0.7\text{mH}$ ,  $R_G=25\Omega$ ,  $I_{DSS}=-6.6\text{A}$  (See Figure 12)  
 $\text{④}$  Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$

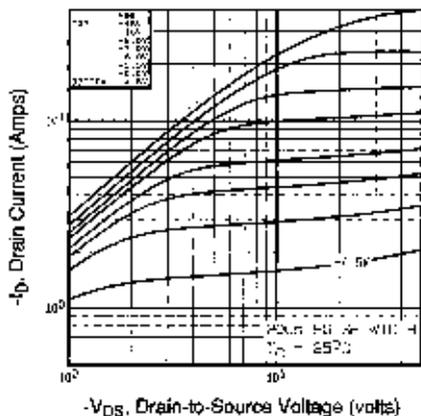


Fig 1. Typical Output Characteristics,  
 $T_C=25^\circ\text{C}$

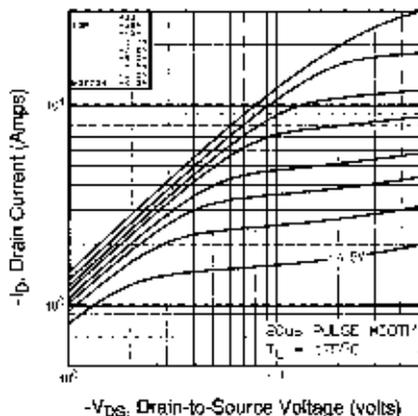


Fig 2. Typical Output Characteristics,  
 $T_C=175^\circ\text{C}$

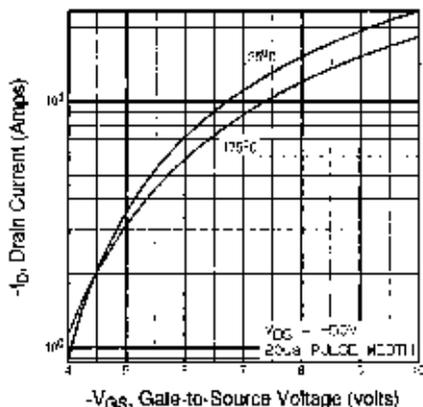


Fig 3. Typical Transfer Characteristics

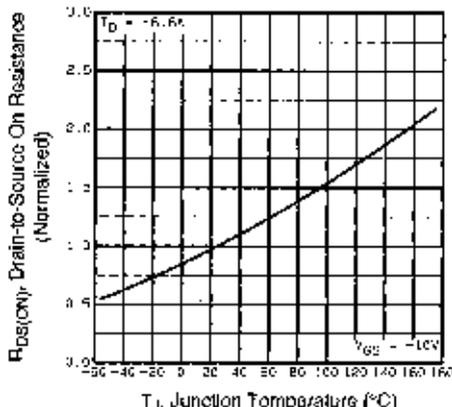
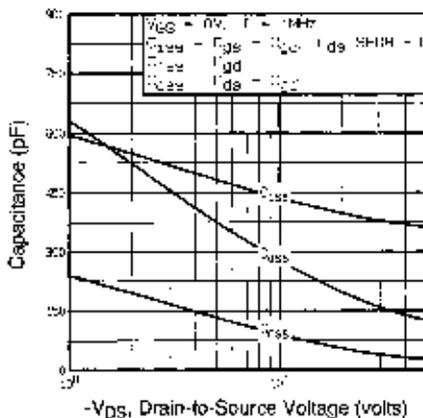
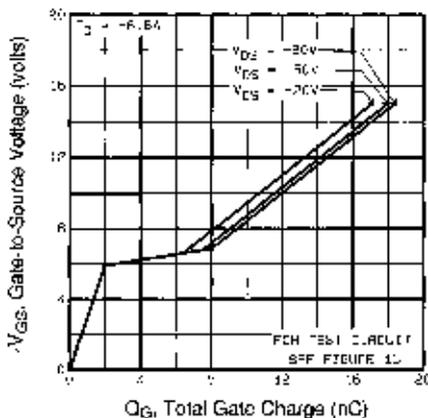


Fig 4. Normalized On-Resistance  
Vs. Temperature

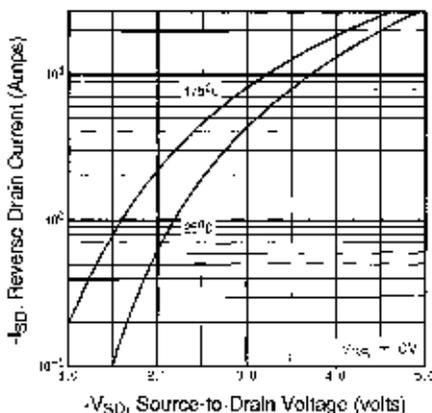
DATA SHEETS



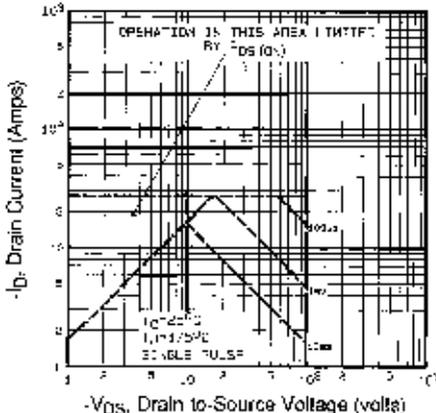
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



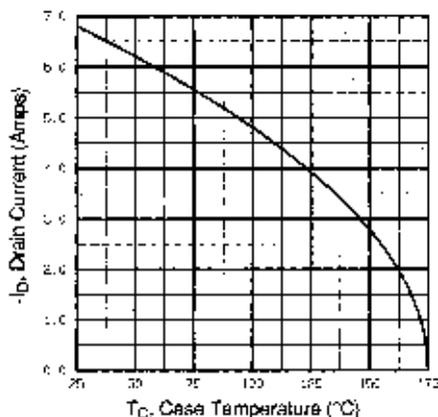
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



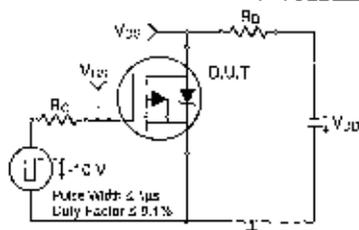
**Fig 7.** Typical Source-Drain Diode Forward Voltage



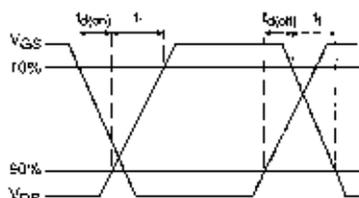
**Fig 8.** Maximum Safe Operating Area



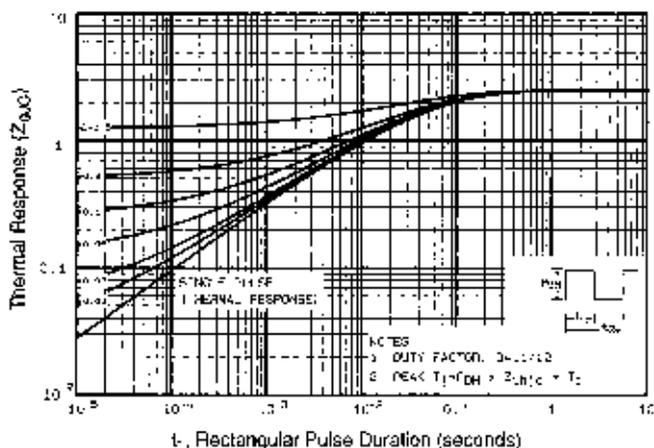
**Fig 9.** Maximum Drain Current Vs. Case Temperature



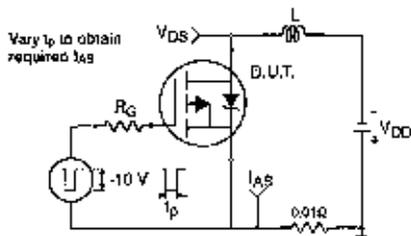
**Fig 10a.** Switching Time Test Circuit



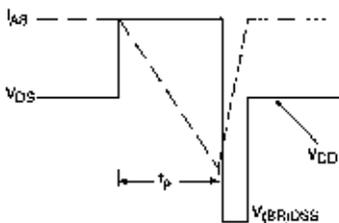
**Fig 10b.** Switching Time Waveforms



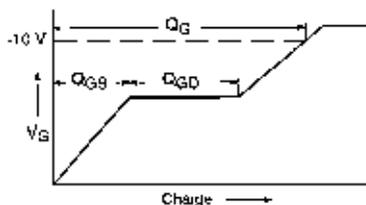
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



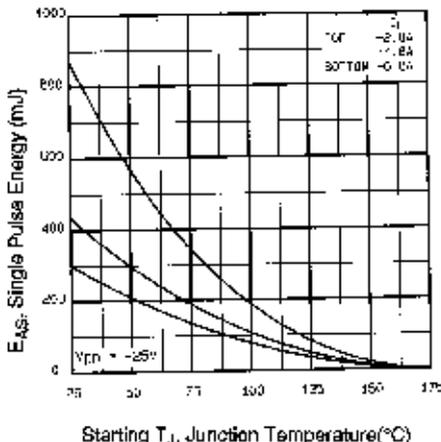
**Fig 12a. Unclamped Inductive Test Circuit**



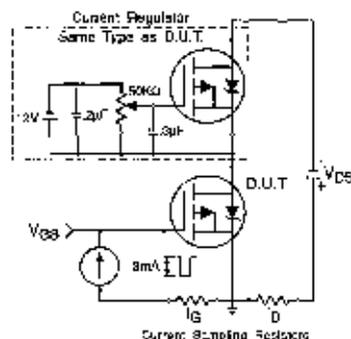
**Fig 12b. Unclamped Inductive Waveforms**



**Fig 13a. Basic Gate Charge Waveform**



**Fig 12c. Maximum Avalanche Energy Vs. Drain Current**



**Fig 13b. Gate Charge Test Circuit**

**Appendix A:** Figure 14. Peak Diode Recovery  $dv/dt$  Test Circuit – See page 1506

**Appendix B:** Package Outline Mechanical Drawing – See page 1509

**Appendix C:** Part Marking Information – See page 1516

**Appendix E:** Optional Leadforms – See page 1525